



DUAL PRECISION CMOS VOLTAGE COMPARATOR WITH PUSH-PULL DRIVER

GENERAL DESCRIPTION

The ALD2302A/ALD2302 are monolithic precision high performance dual voltage comparators built with advanced silicon gate CMOS technology. The primary features are: very high typical input impedance of $10^{12}\Omega$; low input bias current of 10pA; fast response time of 180ns; very low power dissipation of 175 μ A per comparator; and single (+5V) or dual ($\pm$ 5V) power supply operation.

The input voltage range includes ground, which makes these comparators ideal for single supply low level signal detection with high source impedance. The outputs can source and sink current allowing for application flexibility. They can be used in either wired-OR connection without pull-up resistor or push-pull configuration. The ALD2302A/ALD2302 can also be used in wired-OR connection with other open drain circuits such as the ALD2301/ALD2303 voltage comparators.

The ALD2302A/ALD2302 voltage comparators are ideal for a great variety of applications, especially in low level signal detection circuits which require low standby power and high output current. For quad packages, use the ALD4302 quad voltage comparator.

APPLICATIONS

- PCMCIA instruments
- MOSFET driver
- High source impedance voltage comparison circuits
- Multiple limit window comparator
- Power supply voltage monitor
- Photodetector sensor circuit
- High speed LED driver
- Oscillators
- Battery operated instruments
- Remote signal detection
- Multiple relay drivers

BENEFITS

- On-chip input and output buffers
- Precision voltage comparison capability
- Eliminate need for second power supply
- Eliminate pull-up resistor

ORDERING INFORMATION ("L" suffix for lead free version)

Operating Temperature Range *		
-55°C to +125°C	0°C to +70°C	0°C to +70°C
8-Pin CERDIP Package	8-Pin Small Outline Package (SOIC)	8-Pin Plastic Dip Package
ALD2302ADA ALD2302DA	ALD2302ASA ALD2302ASAL ALD2302SA ALD2302SAL	ALD2302APA ALD2302APAL ALD2302PA ALD2302PAL

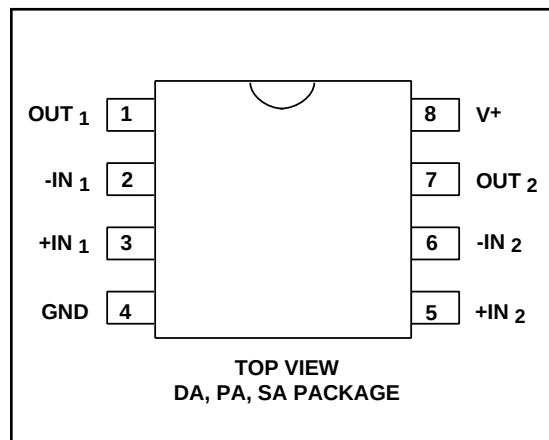
* Contact factory for industrial temperature range

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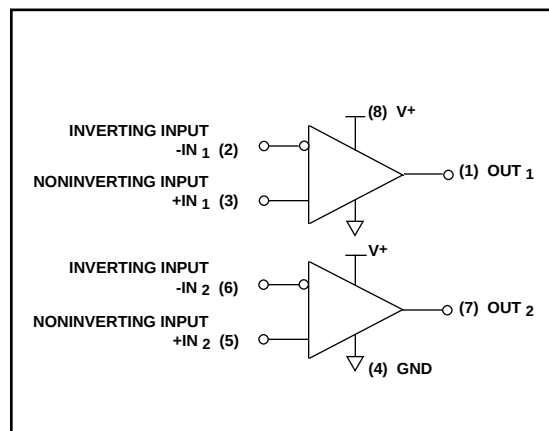
FEATURES

- Guaranteed to drive 200 Ω loads
- Fanout of 30LS TTL loads
- Low supply current of 175 μ A each comparator
- Pinout of LM193 type industry standard comparators
- Extremely low input bias currents -- 10pA
- Virtually eliminates source impedance effects
- Low operating supply voltage of 4V to 12V
- Single (+5V) and dual supply ($\pm$ 5V) operation
- High speed for both large and small signals -- 180ns for TTL inputs and 400ns for 20mV overdrive
- CMOS, NMOS and TTL compatible
- Push-pull outputs-current sourcing/ sinking
- High output sinking current -- 60mA
- Low supply current spikes

PIN CONFIGURATION



BLOCK DIAGRAM



ABSOLUTE MAXIMUM RATINGS

Supply voltage, V^+ _____ 13.2V
Differential input voltage range _____ -0.3V to $V^+ + 0.3V$
Power dissipation _____ 600 mW
Operating temperature range PA, SA package _____ $0^{\circ}C$ to $+70^{\circ}C$
DA package _____ $-55^{\circ}C$ to $+125^{\circ}C$
Storage temperature range _____ $-65^{\circ}C$ to $+150^{\circ}C$
Lead temperature, 10 seconds _____ $+260^{\circ}C$

OPERATING ELECTRICAL CHARACTERISTICS

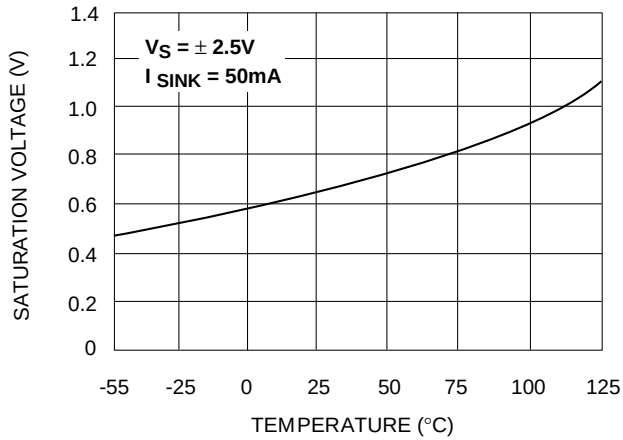
$T_A = 25^{\circ}C$ $V^+ = +5V$ unless otherwise specified

Parameter	Symbol	2302A			2302			Unit	Test Conditions
		Min	Typ	Max	Min	Typ	Max		
Voltage Supply	V_S V^+	± 2 4		± 6 12	± 2 4		± 6 12	V V	Dual Supply Single Supply
Supply Current	I_S		350	500		350	500	μA	$R_{LOAD} = \infty$
Voltage Gain	A_{VD}	10	100		10	100		V/mV	$R_{LOAD} \geq 15K\Omega$
Input Offset Voltage	V_{OS}		1.0	2.0		3.0	5.0	mV	$R_{LOAD} = 1.5K\Omega$ $0^{\circ}C \leq T_A \leq 70^{\circ}C$
Input Offset Current ¹	I_{OS}		10	200 800		10	200 800	pA	
Input Bias Current ¹	I_B		10	200 1000		10	200 1000	pA	$0^{\circ}C \leq T_A \leq 70^{\circ}C$
Common Mode Input Voltage Range ²	V_{ICR}	-0.3		$V^+ - 1.5$	-0.3		$V^+ - 1.5$	V	$0^{\circ}C \leq T_A \leq 70^{\circ}C$
Low Level Output Voltage	V_{OL}		0.18	0.4		0.18	0.4	V	$I_{SINK} = 12mA$ $V_{INPUT} = 1V$ Differential
Low Level Output Current	I_{OL}	24	60		24	60		mA	$V_{OL} = 1.0V$
High Level Output Voltage	V_{OH}	3.5	4.5		3.5	4.5		V	$I_{OH} = -2mA$
Response Time ²	t_{RP}		400			400		ns	$C_L = 15pF$ 100mV Input Step/20mV Overdrive
			180			180		ns	$C_L = 15pF$ TTL- Level Input Step

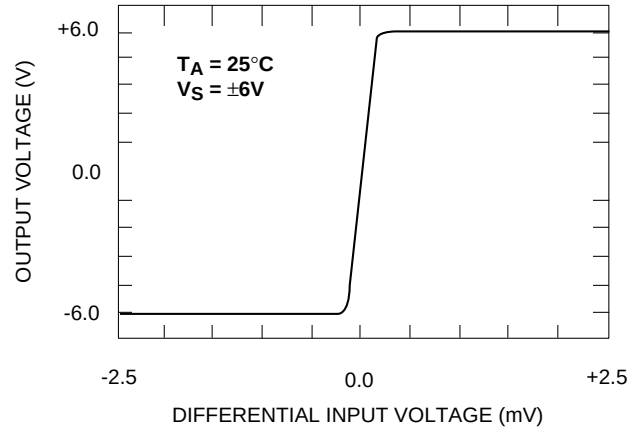
Notes: ¹ Consists of junction leakage currents
² Sample tested parameters

TYPICAL PERFORMANCE CHARACTERISTICS

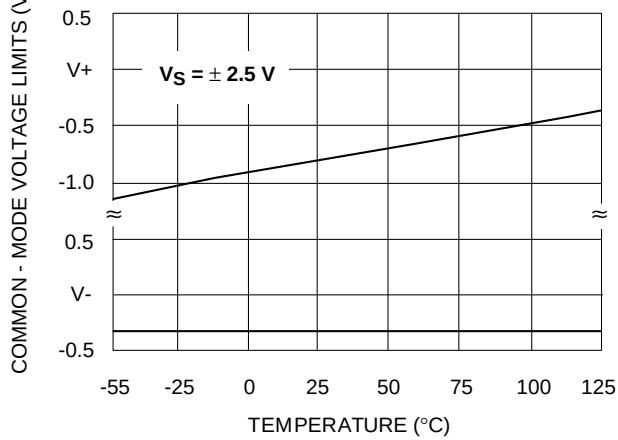
**SATURATION VOLTAGE
vs. TEMPERATURE**



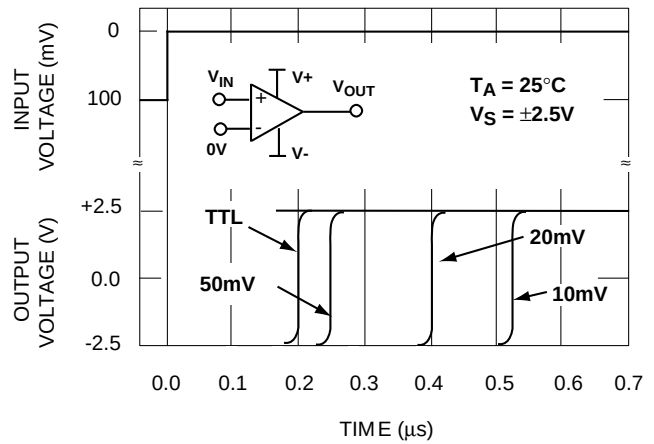
TRANSFER FUNCTION



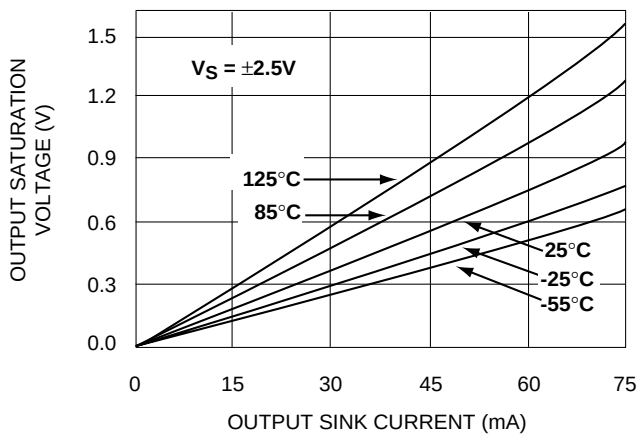
**COMMON - MODE VOLTAGE REFERRED
TO SUPPLY VOLTAGE**



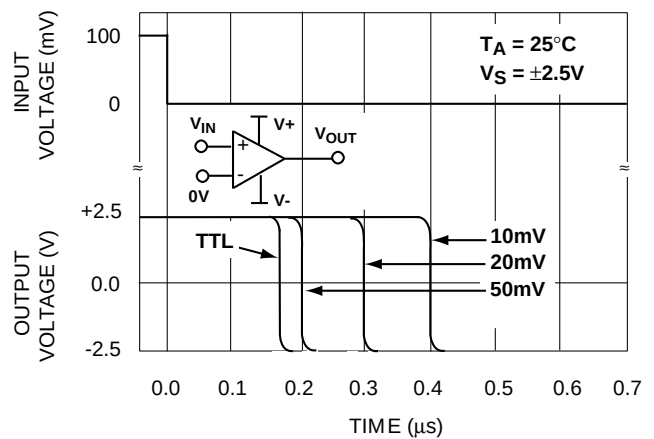
**RESPONSE TIME FOR VARIOUS
INPUT OVERDRIVES**



**SATURATION VOLTAGE vs.
SINK CURRENT**

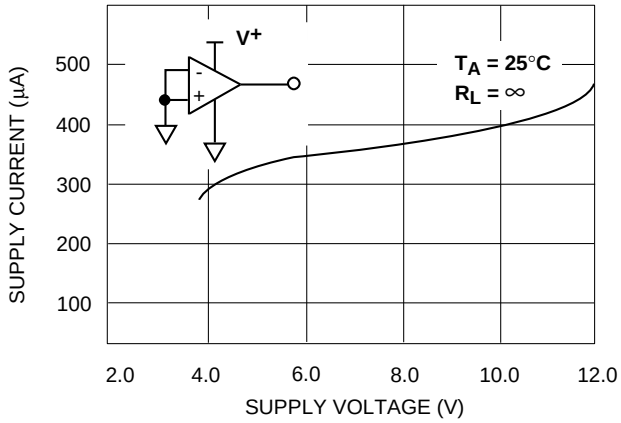


**RESPONSE TIME FOR VARIOUS
INPUT OVERDRIVES**

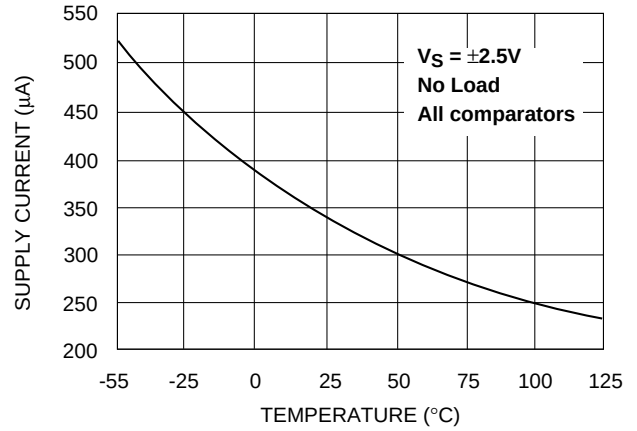


TYPICAL PERFORMANCE CHARACTERISTICS

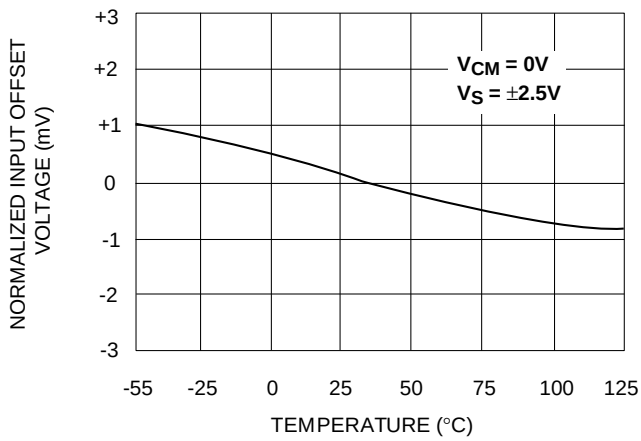
**TOTAL SUPPLY CURRENT vs.
TOTAL SUPPLY VOLTAGE**



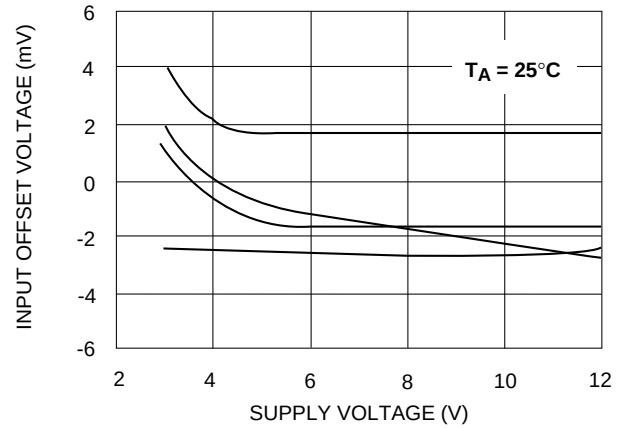
SUPPLY CURRENT vs. TEMPERATURE



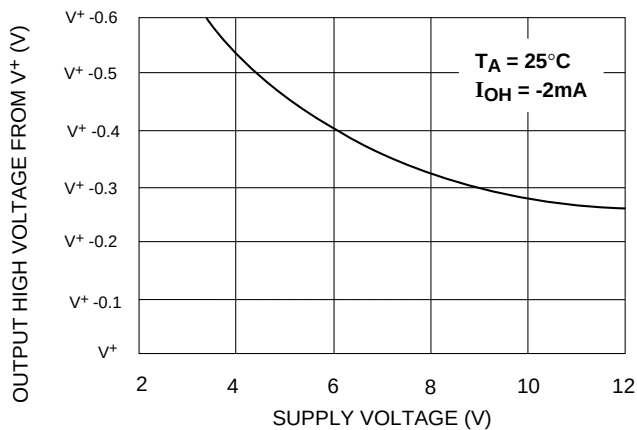
**NORMALIZED INPUT OFFSET VOLTAGE
vs. TEMPERATURE**



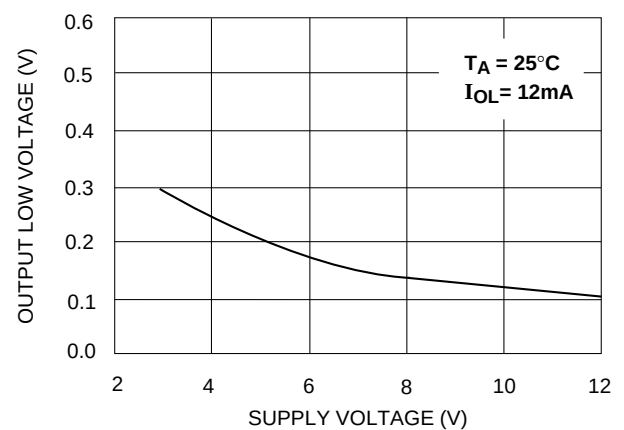
**INPUT OFFSET VOLTAGE vs. SUPPLY
VOLTAGE REPRESENTATIVE SAMPLES**



**OUTPUT HIGH VOLTAGE
vs. SUPPLY VOLTAGE**

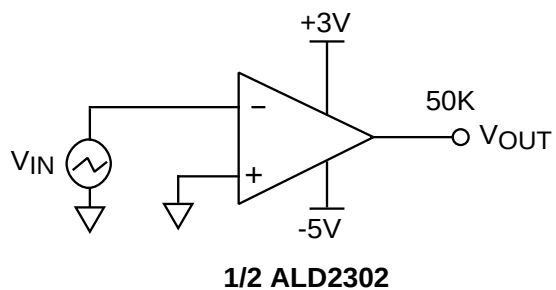


**OUTPUT LOW VOLTAGE
vs. SUPPLY VOLTAGE**

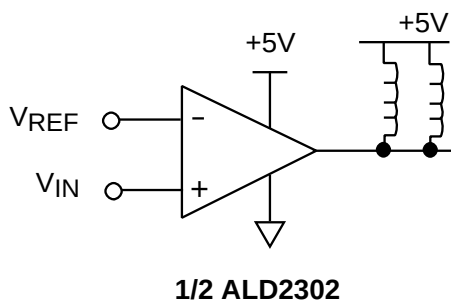


TYPICAL APPLICATIONS

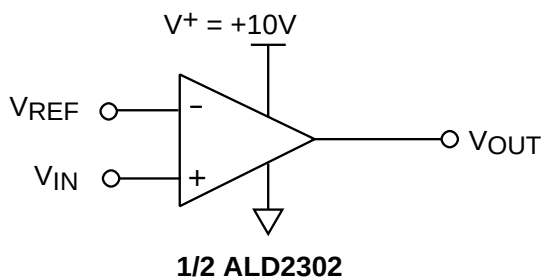
ZERO CROSSING DETECTOR



MULTIPLE RELAY DRIVE



VOLTAGE LEVEL TRANSLATOR

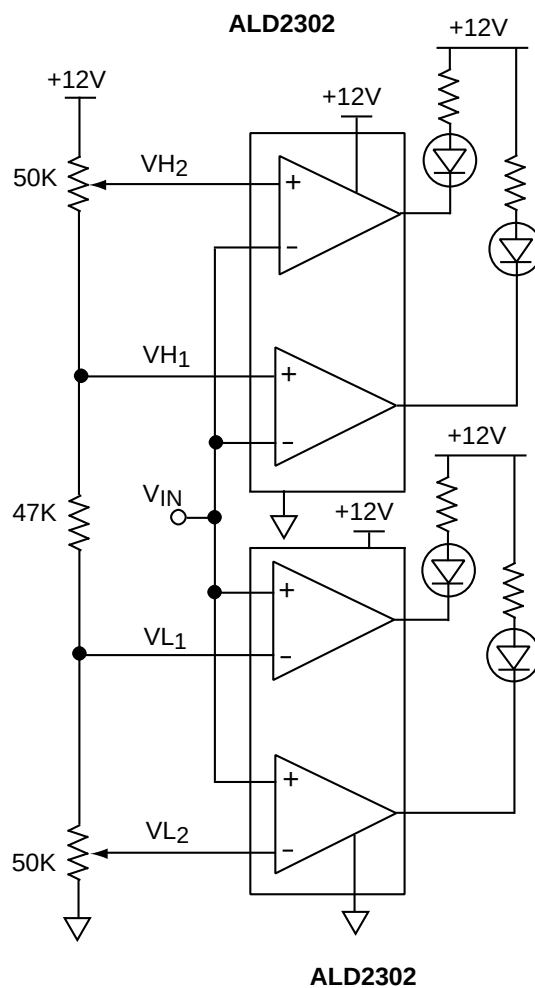


$V_{REF} = 1.4V$ for TTL input

$V_{REF} = \frac{V^+}{2}$ for CMOS input

Output V_{OUT} swings from rail-to-rail

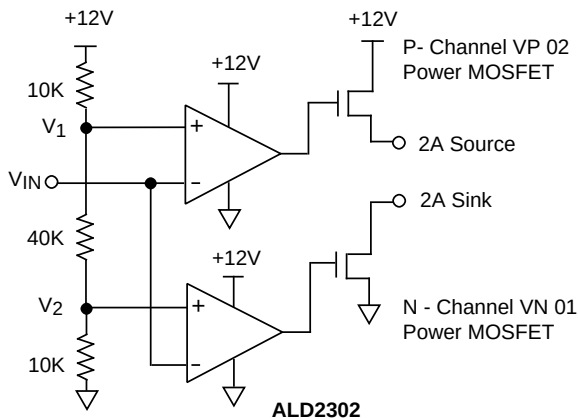
DOUBLE DUAL LIMIT WINDOW COMPARATOR



V_{L1} and V_{H1} first limit window send warning
 V_{L2} and V_{H2} second limit window execute system cutoff

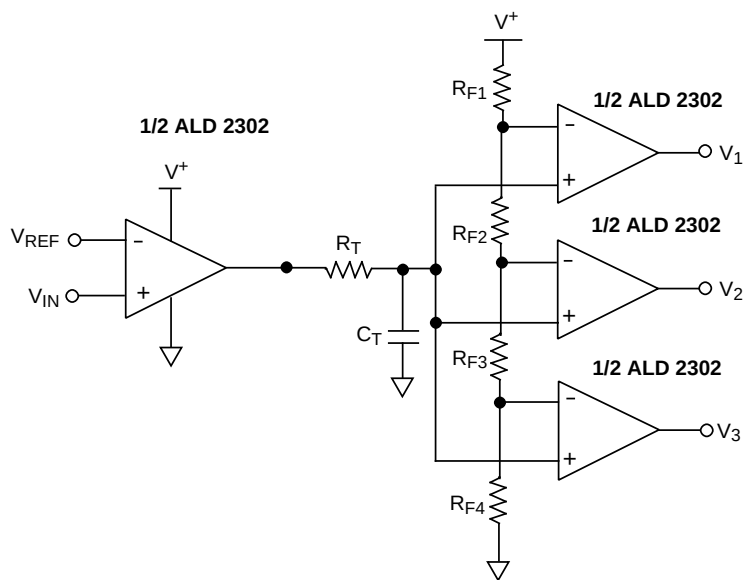
TYPICAL APPLICATIONS

PUSH-PULL COMPLEMENTARY POWER MOSFET DRIVER



This circuit eliminates crossover current in the complementary power transistors. The outputs can be used to source and sink different loads or tied together to provide push-pull drive of the same load.

TIME DELAY GENERATOR



Design & Operating Notes:

1. As each output sources up to 10mA in the output high state, the output stage of a wired - OR low output circuit must be able to sink this current and still provide desired output voltage levels. For TTL output levels, this consideration limits the number to a maximum of three ALD2302 outputs wired-OR together.
2. In order to minimize stray oscillation, all unused inputs must be tied to ground.
3. The input bias and offset currents are essentially input protection diode reverse bias leakage currents, and are typically less than 1 pA at room temperature. The currents are a function of ambient temperature, and would have to be considered in applications where very high source impedance or high accuracy are involved.
4. The high output sinking current of 60mA for each output offers flexibility in many applications, as a separate buffer or driver would not be necessary to drive the intended load. However, as the circuit normally operates close to ambient temperature due to its very low power consumption, thermal effects caused by large output current transients must be considered in certain applications.